

FDD6670AS

30V N-Channel PowerTrench® SyncFET™

General Description

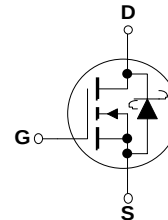
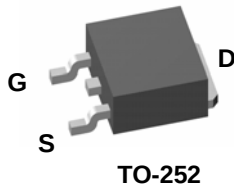
The FDD6670AS is designed to replace a single MOSFET and Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low $R_{DS(ON)}$ and low gate charge. The FDD6670AS includes a patented combination of a MOSFET monolithically integrated with a schottky diode. The performance of the FDD6670AS as the low-side switch in a synchronous rectifier is indistinguishable from the performance of the FDD6670A in parallel with a Schottky diode.

Applications

- DC/DC converter
- Low side notebook

Features

- 76 A, 30 V $R_{DS(ON)} \text{ max} = 8.0 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$
 $R_{DS(ON)} \text{ max} = 10.4 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Includes SyncFET Schottky body diode
- Low gate charge (29nC typical)
- High performance trench technology for extremely low $R_{DS(ON)}$
- High power and current handling capability



Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V _{DSS}	Drain-Source Voltage	30	V
V _{GSS}	Gate-Source Voltage	±20	V
I _D	Drain Current – Continuous (Note 3)	76	A
	– Pulsed (Note 1a)	100	
P _D	Power Dissipation (Note 1)	70	W
		3.2	
		1.3	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	–55 to +150	°C

Thermal Characteristics

R _{θJC}	Thermal Resistance, Junction-to-Case (Note 1)	1.8	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient (Note 1a)	40	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient (Note 1b)	96	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDD6670AS	FDD6670AS	13"	16mm	2500 units
FDD6670AS	FDD6670AS_NL (Note 4)	13"	16mm	2500 units

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Drain-Source Avalanche Ratings (Note 2)						
W _{DSS}	Drain-Source Avalanche Energy	Single Pulse, V _{DD} = 15 V, I _D =14A			245	mJ
I _{AR}	Drain-Source Avalanche Current				14	A
Off Characteristics						
BV _{DSS}	Drain–Source Breakdown Voltage	V _{GS} = 0 V, I _D = 1 mA	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, Referenced to 25°C		29		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			500	μA
		V _{DS} = 24 V, V _{GS} = 0 V, T _J = 125°C		6.5		mA
I _{GSS}	Gate–Body Leakage	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA
On Characteristics (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 1 mA	1	1.8	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I _D = 10 mA, Referenced to 25°C		–3.3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	V _{GS} = 10 V, I _D = 13.8 A V _{GS} = 4.5 V, I _D = 11.7 A V _{GS} = 10 V, I _D = 13.8A, T _J = 125°C		6.8 8.3 9.3	8.0 10.4 11.6	mΩ
I _{D(on)}	On–State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V	50			A
g _{FS}	Forward Transconductance	V _{DS} = 15 V, I _D = 13.8 A		52		S
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz		1580		pF
C _{oss}	Output Capacitance			440		pF
C _{rss}	Reverse Transfer Capacitance			170		pF
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		1.8		Ω
Switching Characteristics (Note 2)						
t _{d(on)}	Turn–On Delay Time	V _{DS} = 15 V, I _D = 1 A, V _{GS} = 10 V, R _{GEN} = 6 Ω		10	20	ns
t _r	Turn–On Rise Time			12	22	ns
t _{d(off)}	Turn–Off Delay Time			28	45	ns
t _f	Turn–Off Fall Time			20	36	ns
t _{d(on)}	Turn–On Delay Time	V _{DS} = 15 V, I _D = 1 A, V _{GS} = 4.5 V, R _{GEN} = 6 Ω		15	27	ns
t _r	Turn–On Rise Time			16	29	ns
t _{d(off)}	Turn–Off Delay Time			26	42	ns
t _f	Turn–Off Fall Time			13	23	ns
Q _{g(TOT)}	Total Gate Charge at V _{GS} =10V	V _{DS} = 15 V, I _D = 13.8 A,		29	40	nC
Q _{g(TOT)}	Total Gate Charge at V _{GS} =5V			16	22	nC
Q _{gs}	Gate–Source Charge			4.6		nC
Q _{gd}	Gate–Drain Charge			5.5		nC
Drain–Source Diode Characteristics						
V _{SD}	Drain–Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 3.5 A (Note 2) V _{GS} = 0 V, I _S = 7 A (Note 2)		0.46 0.59	0.7	V
t _{rr}	Diode Reverse Recovery Time	I _F = 3.5 A,		20		ns
Q _{rr}	Diode Reverse Recovery Charge	d _{IF} /d _t = 300 A/μs (Note 3)		15		nC

Electrical Characteristics

T_A = 25°C unless otherwise noted

Notes:

1. R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.



a) R_{θJA} = 40°C/W when mounted on a 1 in² pad of 2 oz copper



b) R_{θJA} = 96°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

3. Maximum current is calculated as:
$$\sqrt{\frac{P_D}{R_{DS(ON)}}}$$

where P_D is maximum power dissipation at T_C = 25°C and R_{DS(on)} is at T_{J(max)} and V_{GS} = 10V. Package current limitation is 21A

4. FDD6670AS_NL is a lead free product. The FDD6670AS_NL marking will appear on the reel label.

Typical Characteristics

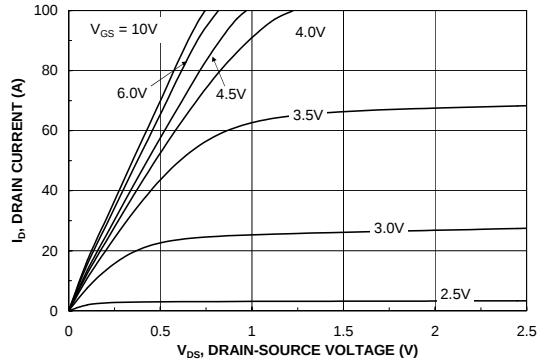


Figure 1. On-Region Characteristics.

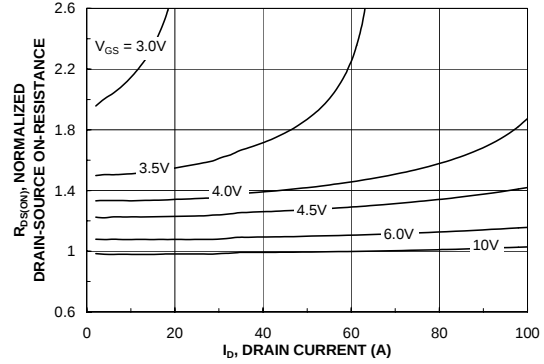


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

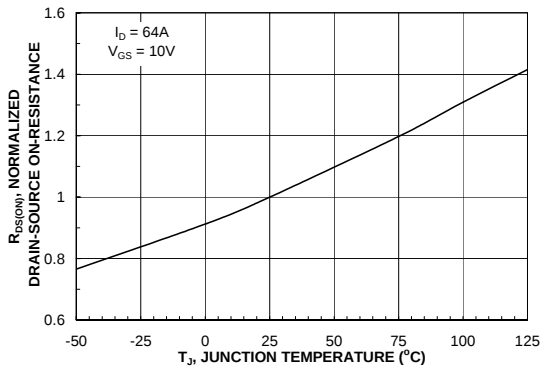


Figure 3. On-Resistance Variation with Temperature.

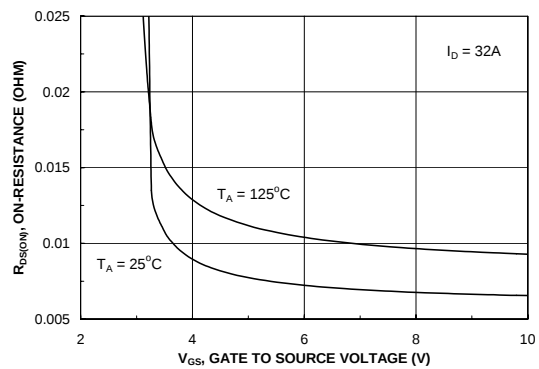


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

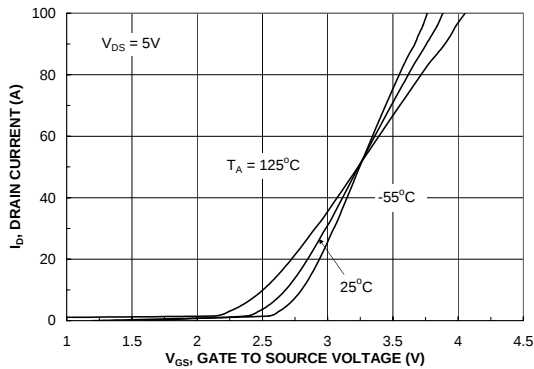


Figure 5. Transfer Characteristics.

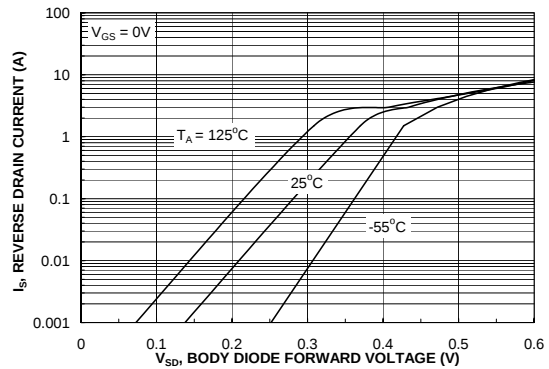


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics (continued)

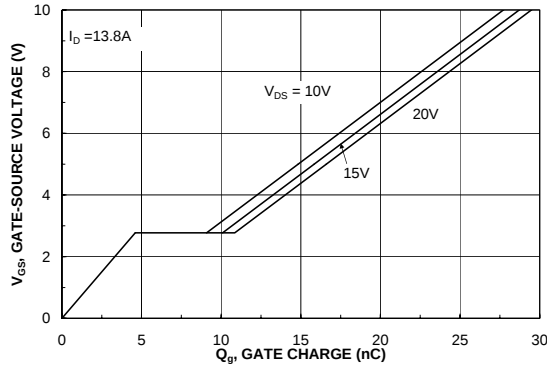


Figure 7. Gate Charge Characteristics.

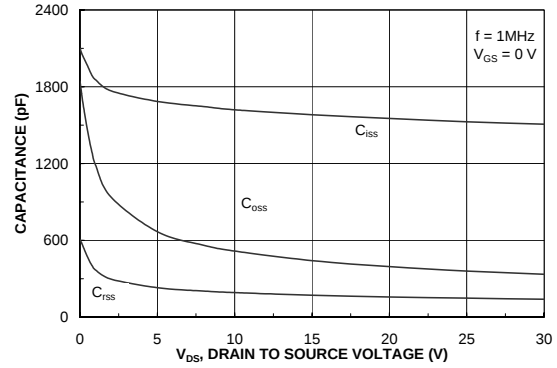


Figure 8. Capacitance Characteristics.

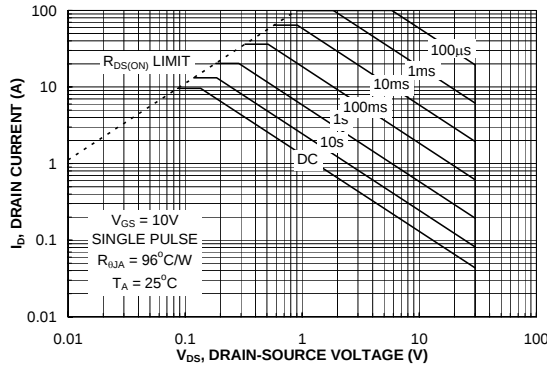


Figure 9. Maximum Safe Operating Area.

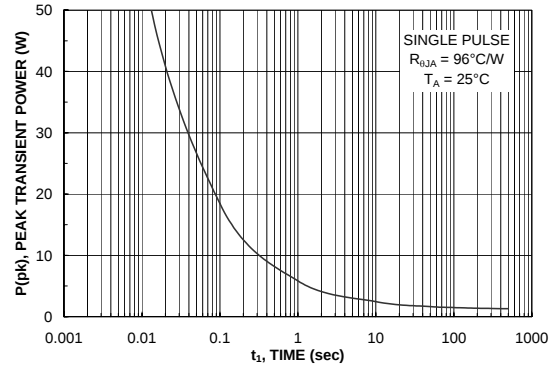


Figure 10. Single Pulse Maximum Power Dissipation.

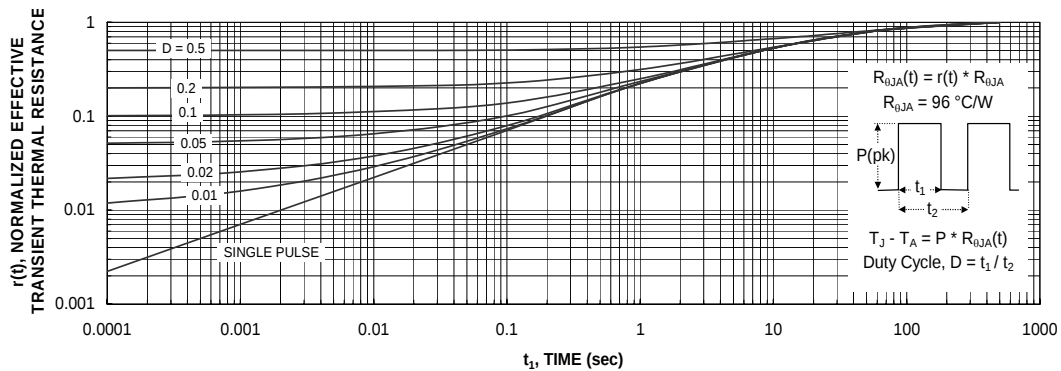


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c.
Transient thermal response will change depending on the circuit board design.

Typical Characteristics (continued)

SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDD6670AS.

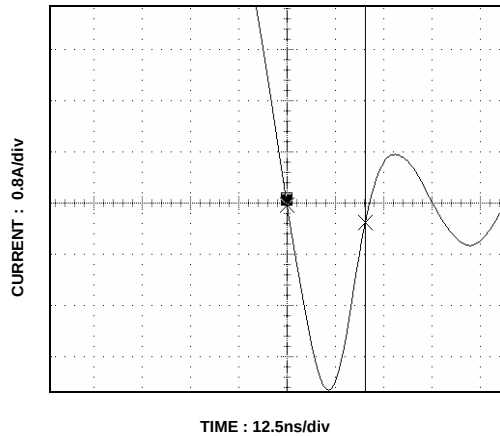


Figure 12. FDD6670AS SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDD6670A).

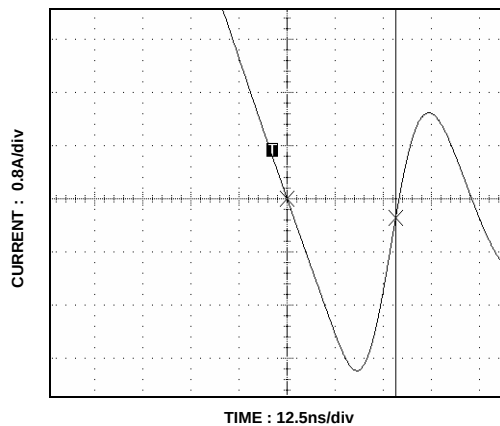


Figure 13. Non-SyncFET (FDD6670A) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

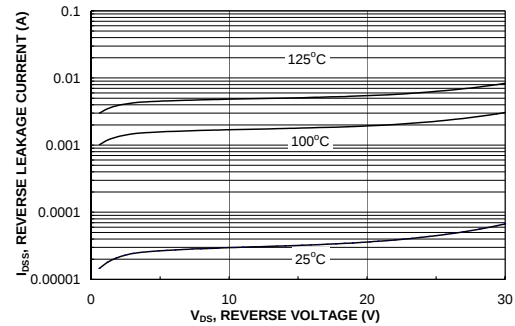


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACE ^x TM	FAST [®]	IntelliMAX TM	POP TM	SPM TM
ActiveArray TM	FAST ^r TM	ISOPLANAR TM	Power247 TM	Stealth TM
Bottomless TM	FPS TM	LittleFET TM	PowerEdge TM	SuperFET TM
CoolFET TM	FRFET TM	MICROCOUPLER TM	PowerSaver TM	SuperSOT TM -.3
CROSSVOLT TM	GlobalOptoisolator TM	MicroFET TM	PowerTrench [®]	SuperSOT TM -.6
DOME TM	GTO TM	MicroPak TM	QFET [®]	SuperSOT TM -.8
EcoSPARK TM	HiSeC TM	MICROWIRE TM	QS TM	SyncFET TM
E ² CMOS TM	I ² C TM	MSX TM	QT Optoelectronics TM	TinyLogic [®]
EnSigna TM	i-Lo TM	MSXPro TM	Quiet Series TM	TINYOPTO TM
FACT TM	ImpliedDisconnect TM	OCX TM	RapidConfigure TM	TruTranslation TM
FACT Quiet Series TM		OCXPro TM	RapidConnect TM	UHC TM
Across the board. Around the world. TM		OPTOLOGIC [®]	μSerDes TM	UltraFET [®]
The Power Franchise [®]		OPTOPLANAR TM	SILENT SWITCHER [®]	UniFET TM
Programmable Active Droop TM		PACMAN TM	SMART START TM	VCX TM

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный)

Факс: 8 (812) 320-02-42

Электронная почта: org@eplast1.ru

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.